

**Search Notes**

Application/Control No.

10/672,357

Examiner

Binh X. Tran

Applicant(s)/Patent under  
Reexamination

FU ET AL.

Art Unit

1765

**SEARCHED**

Class	Subclass	Date	Examiner
438	708	12/1/2005	BT
438	709	12/1/2005	BT
438	717	12/1/2005	BT
438	725	12/1/2005	BT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search keywords and inventors' name using USPAT, USPG-PUB, JPO, EPO, DERWENT databases	12/1/2005	BT